

**Search Notes**

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Examiner

Richard H. Kim

Applicant(s)/Patent under  
Reexamination

CHAE ET AL.

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Text Search (349/\$)-see printout history	9/2/2006	RHK